

FEATURES

- Operates With 3-V to 5.5-V V_{CC} Supply
- Operates up to 1 Mbit/s
- Low Standby Current . . . 1 µA Typical
- External Capacitors . . . 4 \times 0.1 μF
- Accepts 5-V Logic Input With 3.3-V Supply
- Latch-Up Performance Exceeds 100 mA Per JESD 78, Class II
- RS-232 Bus-Pin ESD Protection Exceeds ±15 kV Using Human-Body Model (HBM)

APPLICATIONS

- Battery-Powered Systems
- PDAs
- Notebooks
- Laptops
- Palmtop PCs
- Hand-Held Equipment

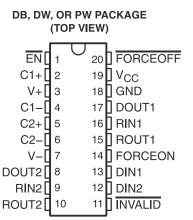
DESCRIPTION/ORDERING INFORMATION

The TRSF3223 consists of two line drivers, two line receivers, and a dual charge-pump circuit with \pm 15-kV ESD protection pin to pin (serial-port connection pins, including GND). The device provides the electrical interface between an asynchronous communication controller and the serial-port connector. The charge pump and four small external capacitors allow operation from a single 3-V to 5.5-V supply. The device operates at data signaling rates up to 1 Mbit/s and a driver output slew rate of 24 V/µs to 150 V/µs.

Flexible control options for power management are available when the serial port is inactive. The auto-powerdown feature functions when FORCEON is low and FORCEOFF is high. During this mode of operation, if the device does not sense a valid RS-232 signal, the driver outputs are disabled. If FORCEOFF is set low and enable (\overline{EN}) is high, both drivers and receivers are shut off, and the supply current is reduced to 1 μ A. Disconnecting the serial port or turning off the peripheral drivers causes auto-powerdown to occur. Auto-powerdown can be disabled when FORCEON and FORCEOFF are high. With auto-powerdown enabled, the device is activated automatically when a valid signal is applied to any receiver input. The INVALID output is used to notify the user if an RS-232 signal is present at any receiver input. INVALID is high (valid data) if any receiver input voltage is greater than 2.7 V or less than -2.7 V or has been between -0.3 V and 0.3 V for less than 30 μ s. INVALID is low (invalid data) if the receiver input voltage is between -0.3 V and 0.3 V for more than 30 μ s. Refer to Figure 4 for receiver input levels.



Please be aware that an important notice concerning availability, standard warranty, and use in critical applications of Texas Instruments semiconductor products and disclaimers thereto appears at the end of this data sheet.





ORDERING INFORMATION

T _A	PAC	KAGE ⁽¹⁾⁽²⁾	ORDERABLE PART NUMBER	TOP-SIDE MARKING
	SOIC – DW	Tube of 25	TRSF3223CDW	TRSF3223C
	3010 - 010	Reel of 2000	TRSF3223CDWR	183532230
0°C to 70°C		Tube of 70	TRSF3223CDB	RT23C
	SSOP – DB	Reel of 2000	TRSF3223CDBR	- R1230
	TSSOP – PW	Tube of 70	TRSF3223CPW	RT23C
	1330P - PW	Reel of 2000	TRSF3223CPWR	- R1230
	SOIC - DW	Tube of 25	TRSF3223IDW	- TRSF3223I
	50IC - DW	Reel of 2000	TRSF3223IDWR	- 185532231
40°C to 85°C	SSOP – DB	Tube of 70	TRSF3223IDB	- RT23I
–40°C to 85°C	550P - DB	Reel of 2000	TRSF3223IDBR	- R1231
	TSSOP – PW	Tube of 70	TRSF3223IPW	- RT23I
	1330F - PW	Reel of 2000	TRSF3223IPWR	R I Z JI

(1) Package drawings, thermal data, and symbolization are available at www.ti.com/packaging.

(2) For the most current package and ordering information, see the Package Option Addendum at the end of this document, or see the TI website at www.ti.com.

FUNCTION TABLES

Each Driver⁽¹⁾

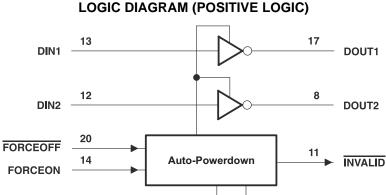
		INPUTS		OUTPUT	
DIN	FORCEON	FORCEOFF	VALID RIN RS-232 LEVEL	DOUT	DRIVER STATUS
Х	Х	L	Х	Z	Powered off
L	н	Н	Х	Н	Normal operation with
н	н	н	х	L	auto-powerdown disabled
L	L	Н	Yes	Н	Normal operation with
н	L	Н	Yes	L	auto-powerdown enabled
L	L	Н	No	Z	Powered off by
Н	L	Н	No	Z	auto-powerdown feature

(1) H = high level, L = low level, X = irrelevant, Z = high impedance

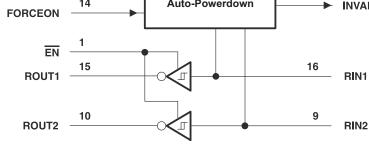
Each Receiver⁽¹⁾

	INPU	rs	OUTPUT
RIN	RIN EN VA RS-2		ROUT
L	L	Х	Н
н	L	Х	L
х	Н	Х	Z
Open	L	No	Н

 (1) H = high level, L = low level, X = irrelevant, Z = high impedance (off), Open = input disconnected or connected driver off



LOGIC DIAGRAM (POSITIVE LOGIC)



Absolute Maximum Ratings⁽¹⁾

over operating free-air temperature range (unless otherwise noted)

			MIN	MAX	UNIT	
V _{CC}	Supply voltage range ⁽²⁾		-0.3	6	V	
V+	Positive-output supply voltage range ⁽²⁾		-0.3	7	V	
V–	Negative-output supply voltage range ⁽²⁾		0.3	-7	V	
V+ - V-	Supply voltage difference ⁽²⁾			13	V	
V		Driver (FORCEOFF, FORCEON, EN)	-0.3	6		
VI	Input voltage range	Receiver	-25	25	V	
M	Output voltage range	Driver	-13.23	13.2	N	
Vo		Receiver (INVALID)	-0.3	V _{CC} + 0.3	V	
		DB package		70		
θ_{JA}	Package thermal impedance ⁽³⁾⁽⁴⁾	DW package		58	°C/W	
		PW package		83	l	
TJ	Operating virtual junction temperature	·		150	°C	
T _{stg}	Storage temperature range		-65	150	°C	

Stresses beyond those listed under "absolute maximum ratings" may cause permanent damage to the device. These are stress ratings (1) only, and functional operation of the device at these or any other conditions beyond those indicated under "recommended operating conditions" is not implied. Exposure to absolute-maximum-rated conditions for extended periods may affect device reliability.

All voltages are with respect to network GND. (2)

Maximum power dissipation is a function of T_J(max), θ_{JA}, and T_A. The maximum allowable power dissipation at any allowable ambient (3) temperature is $P_D = (T_J(max) - T_A)/\theta_{JA}$. Operating at the absolute maximum T_J of 150°C can affect reliability. The package thermal impedance is calculated in accordance with JESD 51-7.

(4)

SLLS854-AUGUST 2007

Recommended Operating Conditions⁽¹⁾

See Figure 6

				MIN	NOM	MAX	UNIT
	Supply voltage		$V_{CC} = 3.3 V$	3	3.3	3.6	V
			$V_{CC} = 5 V$	4.5	5	5.5	v
V	Driver and control	DIN, EN, FORCEOFF, FORCEON	$V_{CC} = 3.3 V$	2			V
VIH	high-level input voltage	DIN, EN, FORCEOFF, FORCEON	$V_{CC} = 5 V$	2.4			v
V_{IL}	Driver and control low-level input voltage	DIN, EN, FORCEOFF, FORCEON	DIN, EN, FORCEOFF, FORCEON			0.8	V
V	Driver and control input voltage	DIN, EN, FORCEOFF, FORCEON		0		5.5	V
VI	Receiver input voltage			-25		25	v
т	Operating free-air temperature		TRSF3223C	0		70	°C
T _A			TRSF3223I	-40		85	

(1) Test conditions are C1–C4 = 0.1 μ F at V_{CC} = 3.3 V \pm 0.3 V; C1 = 0.047 μ F, C2–C4 = 0.33 μ F at V_{CC} = 5 V \pm 0.5 V.

Electrical Characteristics⁽¹⁾

over recommended ranges of supply voltage and operating free-air temperature (unless otherwise noted) (see Figure 5)

	PARAMETER		TEST CONDITIONS	MIN	TYP ⁽²⁾	MAX	UNIT
I _I	Input leakage current	EN, FORCEOFF, FORCEON			±0.01	±1	μA
	Supply current	Auto-powerdown disabled	No load, FORCEOFF, FORCEON at V _{CC}		0.3	1	mA
Icc		Powered off	No load, FORCEOFF at GND		1	10	
		Auto-powerdown enabled	No load, FORCEOFF at V _{CC} , FORCEON at GND, All RIN are open or grounded		1	10	μA

(1) Test conditions are C1–C4 = 0.1 μ F at V_{CC} = 3.3 V ± 0.3 V; C1 = 0.047 μ F, C2–C4 = 0.33 μ F at V_{CC} = 5 V ± 0.5 V. (2) All typical values are at V_{CC} = 3.3 V or V_{CC} = 5 V, and T_A = 25°C.

DRIVER SECTION

Electrical Characteristics⁽¹⁾

over recommended ranges of supply voltage and operating free-air temperature (unless otherwise noted) (see Figure 6)

	PARAMETER	Т	EST CONDITIO	NS	MIN	TYP ⁽²⁾	MAX	UNIT	
V_{OH}	High-level output voltage	DOUT at $R_L = 3 k\Omega$ to G	DOUT at $R_L = 3 k\Omega$ to GND		5	5.4		V	
V _{OL}	Low-level output voltage	DOUT at $R_L = 3 k\Omega$ to G	DOUT at $R_L = 3 k\Omega$ to GND		-5	-5.4		V	
I _{IH}	High-level input current	$V_I = V_{CC}$	$I = V_{CC}$			±0.01	±1	μA	
I_{IL}	Low-level input current	V _I at GND				±0.01	±1	μA	
	Short-circuit output	V _{CC} = 3.6 V,	$V_{O} = 0 V$			±35	±60	~ ^	
IOS	current ⁽³⁾	V _{CC} = 5.5 V,	$V_0 = 0 V$			±35	±90	mA	
r _o	Output resistance	V_{CC} , V+, and V- = 0 V,	$V_0 = \pm 2 V$		300	10M		Ω	
		FORCEOFF = GND	$V_0 = \pm 12 V$,	V_{CC} = 3 V to 3.6 V			±25		
loff	Oulput leakage current	Output leakage current FORCEOFF = GN	FURGEOFF = GND	$V_{O} = \pm 10 V$,	V_{CC} = 4.5 V to 5.5 V			±25	μA

(1) Test conditions are C1–C4 = 0.1 μ F at V_{CC} = 3.3 V ± 0.3 V; C1 = 0.047 μ F, C2–C4 = 0.33 μ F at V_{CC} = 5 V ± 0.5 V. (2) All typical values are at V_{CC} = 3.3 V or V_{CC} = 5 V, and T_A = 25°C. (3) Short-circuit durations should be controlled to prevent exceeding the device absolute power dissipation ratings, and not more than one output should be shorted at a time.

Switching Characteristics⁽¹⁾

over recommended ranges of supply voltage and operating free-air temperature (unless otherwise noted) (see Figure 6)

	PARAMETER		TEST CONDITIONS	6	MIN	TYP ⁽²⁾	MAX	UNIT
		_	C _L = 1000 pF		250			
		$R_L = 3 k\Omega$, One DOUT switching	C _L = 250 pF,	V_{CC} = 3 V to 4.5 V	1000			kbit/s
			C _L = 1000 pF,	V_{CC} = 4.5 V to 5.5 V	1000			
t _{sk(p)}	Pulse skew ⁽³⁾	$C_{L} = 150 \text{ pF} \text{ to } 2500 \text{ pF},$	$R_L = 3 \ k\Omega$ to 7 $k\Omega$,	See Figure 2		300		ns
SR(tr)	Slew rate, transition region (see Figure 1)	V _{CC} = 3.3 V,	$R_L = 3 \ k\Omega$ to 7 $k\Omega$,	C_L = 150 pF to 1000 pF	18		150	V/µs

(1) Test conditions are C1–C4 = 0.1 μ F at V_{CC} = 3.3 V ± 0.3 V; C1 = 0.047 μ F, C2–C4 = 0.33 μ F at V_{CC} = 5 V ± 0.5 V. (2) All typical values are at V_{CC} = 3.3 V or V_{CC} = 5 V, and T_A = 25°C. (3) Pulse skew is defined as |t_{PLH} - t_{PHL}| of each channel of the same device.

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RECEIVER SECTION

Electrical Characteristics⁽¹⁾

over recommended ranges of supply voltage and operating free-air temperature (unless otherwise noted) (see Figure 6)

	PARAMETER	TEST CONDITIONS	MIN	TYP ⁽²⁾	MAX	UNIT
V_{OH}	High-level output voltage	$I_{OH} = -1 \text{ mA}$	$V_{CC} - 0.6$	$V_{CC} - 0.1$		V
V _{OL}	Low-level output voltage	I _{OL} = 1.6 mA			0.4	V
V _{IT+}	Positive-going input threshold voltage	$V_{CC} = 3.3 V$		1.6	2.4	V
		$V_{CC} = 5 V$		1.9	2.4	v
V	Negative-going input threshold voltage	$V_{CC} = 3.3 V$	0.6	1.1		V
V _{IT}	Negative-going input theshold voltage	$V_{CC} = 5 V$	0.8	1.4		v
V _{hys}	Input hysteresis (V _{IT+} - V _{IT-})			0.5		V
I _{off}	Output leakage current	$\overline{EN} = V_{CC}$		±0.05	±10	μA
ri	Input resistance	$V_1 = \pm 3 \text{ V to } \pm 25 \text{ V}$	3	5	7	kΩ

(1) Test conditions are C1–C4 = 0.1 μ F at V_{CC} = 3.3 V ± 0.3 V; C1 = 0.047 μ F, C2–C4 = 0.33 μ F at V_{CC} = 5 V ± 0.5 V. (2) All typical values are at V_{CC} = 3.3 V or V_{CC} = 5 V, and T_A = 25°C.

Switching Characteristics⁽¹⁾

over recommended ranges of supply voltage and operating free-air temperature (unless otherwise noted)

	PARAMETER	TEST CONDITIONS			TYP ⁽²⁾	UNIT
t _{PLH}	Propagation delay time, low- to high-level output	C _L = 150 pF,	See Figure 3		150	ns
t _{PHL}	Propagation delay time, high- to low-level output	C _L = 150 pF,	See Figure 3		150	ns
t _{en}	Output enable time	C _L = 150 pF,	$R_L = 3 k\Omega$,	See Figure 4	200	ns
t _{dis}	Output disable time	C _L = 150 pF,	$R_L = 3 k\Omega$,	See Figure 4	200	ns
t _{sk(p})	Pulse skew ⁽³⁾	See Figure 3			50	ns

(1) Test conditions are C1–C4 = 0.1 μ F at V_{CC} = 3.3 V ± 0.3 V; C1 = 0.047 μ F, C2–C4 = 0.33 μ F at V_{CC} = 5 V ± 0.5 V. (2) All typical values are at V_{CC} = 3.3 V or V_{CC} = 5 V, and T_A = 25°C. (3) Pulse skew is defined as |t_{PLH} - t_{PHL}| of each channel of the same device.

AUTO-POWERDOWN SECTION

Electrical Characteristics

over recommended ranges of supply voltage and operating free-air temperature (unless otherwise noted) (see Figure 5)

PARAMETER		TEST CONDITIONS		MIN	MAX	UNIT
V _{T+(valid)}	Receiver input threshold for INVALID high-level output voltage	FORCEON = GND,	$\overline{FORCEOFF} = V_{CC}$		2.7	V
V _{T-(valid)}	Receiver input threshold for INVALID high-level output voltage	FORCEON = GND,	$\overline{FORCEOFF} = V_{CC}$	-2.7		V
V _{T(invalid)}	Receiver input threshold for INVALID low-level output voltage	FORCEON = GND,	$\overline{FORCEOFF} = V_{CC}$	-0.3	0.3	V
V _{OH}	INVALID high-level output voltage	$I_{OH} = 1 \text{ mA},$ FORCEOFF = V _{CC}	FORCEON = GND,	V _{CC} - 0.6		V
V _{OL}	INVALID low-level output voltage	$I_{OL} = 1.6 \text{ mA},$ FORCEOFF = V _{CC}	FORCEON = GND,		0.4	V

Switching Characteristics

over recommended ranges of supply voltage and operating free-air temperature (unless otherwise noted) (see Figure 5)

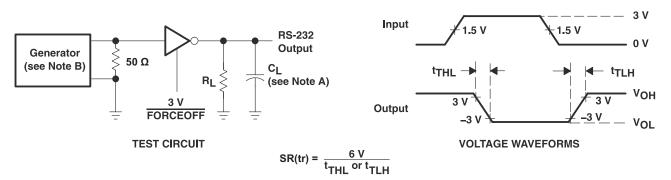
	PARAMETER	TYP ⁽¹⁾	UNIT
t _{valid}	Propagation delay time, low- to high-level output	1	μs
t _{invalid}	Propagation delay time, high- to low-level output	30	μs
t _{en}	Supply enable time	100	μs

(1) All typical values are at V_{CC} = 3.3 V or V_{CC} = 5 V, and T_A = 25 ^{\circ}C.

SLLS854-AUGUST 2007

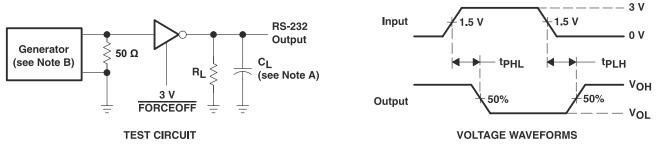


PARAMETER MEASUREMENT INFORMATION



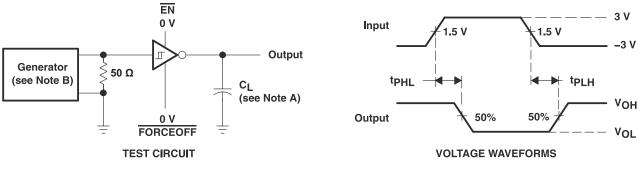
- A. C_L includes probe and jig capacitance.
- B. The pulse generator has the following characteristics: PRR = 250 kbits/s, Z_O = 50 Ω , 50% duty cycle, $t_r \le 10$ ns, $t_f \le 10$ ns.

Figure 1. Driver Slew Rate



- A. C_L includes probe and jig capacitance.
- B. The pulse generator has the following characteristics: PRR = 250 kbits/s, $Z_O = 50 \Omega$, 50% duty cycle, $t_r \le 10$ ns, $t_f \le 10$ ns.





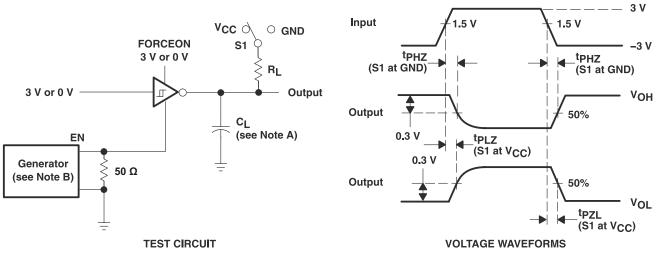
- A. C_L includes probe and jig capacitance.
- B. The pulse generator has the following characteristics: Z₀ = 50 Ω , 50% duty cycle, t_r ≤ 10 ns, t_f ≤ 10 ns.

Figure 3. Receiver Propagation Delay Times



SLLS854-AUGUST 2007

PARAMETER MEASUREMENT INFORMATION (continued)



A. C_L includes probe and jig capacitance.

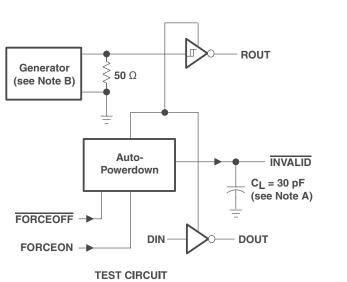
B. The pulse generator has the following characteristics: Z₀ = 50 Ω , 50% duty cycle, t_r \leq 10 ns, t_f \leq 10 ns.

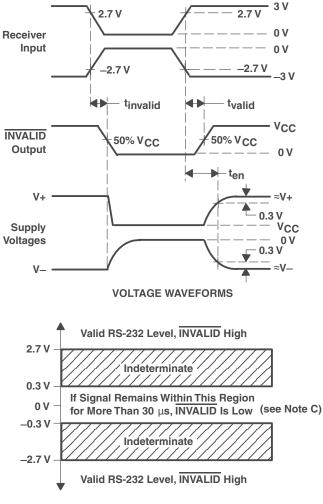
Figure 4. Receiver Enable and Disable Times

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PARAMETER MEASUREMENT INFORMATION (continued)



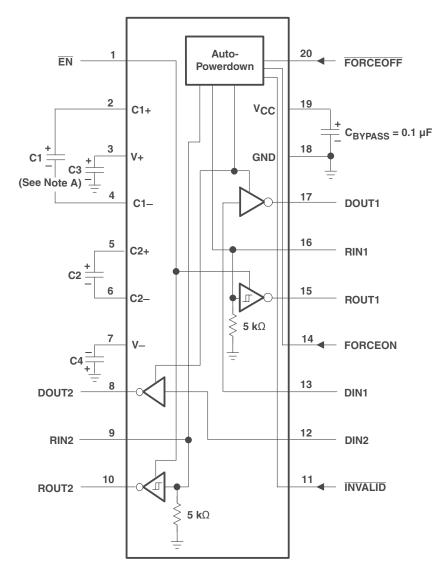


- A. C_L includes probe and jig capacitance.
- B. The pulse generator has the following characteristics: PRR = 5 kbits/s, Z_0 = 50 Ω , 50% duty cycle, $t_r \le 10$ ns, $t_f \le 10$ ns.
- C. Auto-powerdown disables drivers and reduces supply current to 1 μ A.

Figure 5. INVALID Propagation Delay Times and Supply Enabling Time

SLLS854-AUGUST 2007

APPLICATION INFORMATION



Vcc vs	CAPACITOR VALUES
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V _{CC}	C1	C2, C3, C4
$\begin{array}{c} 3.3 \ V \ \pm \ 0.3 \ V \\ 5 \ V \ \pm \ 0.5 \ V \\ 3 \ V \ to \ 5.5 \ V \end{array}$	0.1 μF 0.047 μF 0.1 μF	0.1 μF 0.33 μF 0.47 μF

- A. C3 can be connected to $V_{CC} \mbox{ or } GND.$
- B. Resistor values shown are nominal.

Figure 6. Typical Operating Circuit and Capacitor Values



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24-Jul-2010

PACKAGING INFORMATION

Orderable Device	Status ⁽¹⁾	Package Type	Package Drawing	Pins	Package Qty	Eco Plan ⁽²⁾	Lead/ Ball Finish	MSL Peak Temp ⁽³⁾	Samples (Requires Login)
TRSF3223CDB	ACTIVE	SSOP	DB	20		TBD	Call TI	Call TI	Purchase Samples
TRSF3223CDBG4	ACTIVE	SSOP	DB	20		TBD	Call TI	Call TI	Purchase Samples
TRSF3223CDBR	ACTIVE	SSOP	DB	20		TBD	Call TI	Call TI	Purchase Samples
TRSF3223CDBRG4	ACTIVE	SSOP	DB	20		TBD	Call TI	Call TI	Purchase Samples
TRSF3223CDW	ACTIVE	SOIC	DW	20		TBD	Call TI	Call TI	Purchase Samples
TRSF3223CDWG4	ACTIVE	SOIC	DW	20		TBD	Call TI	Call TI	Purchase Samples
TRSF3223CDWR	ACTIVE	SOIC	DW	20		TBD	Call TI	Call TI	Purchase Samples
TRSF3223CDWRG4	ACTIVE	SOIC	DW	20		TBD	Call TI	Call TI	Purchase Samples
TRSF3223CPW	ACTIVE	TSSOP	PW	20		TBD	Call TI	Call TI	Purchase Samples
TRSF3223CPWG4	ACTIVE	TSSOP	PW	20		TBD	Call TI	Call TI	Purchase Samples
TRSF3223CPWR	ACTIVE	TSSOP	PW	20		TBD	Call TI	Call TI	Purchase Samples
TRSF3223CPWRG4	ACTIVE	TSSOP	PW	20		TBD	Call TI	Call TI	Purchase Samples
TRSF3223IDB	ACTIVE	SSOP	DB	20		TBD	Call TI	Call TI	Purchase Samples
TRSF3223IDBG4	ACTIVE	SSOP	DB	20		TBD	Call TI	Call TI	Purchase Samples
TRSF3223IDBR	ACTIVE	SSOP	DB	20		TBD	Call TI	Call TI	Purchase Samples
TRSF3223IDBRG4	ACTIVE	SSOP	DB	20		TBD	Call TI	Call TI	Purchase Samples
TRSF3223IDW	ACTIVE	SOIC	DW	20		TBD	Call TI	Call TI	Purchase Samples
TRSF3223IDWG4	ACTIVE	SOIC	DW	20		TBD	Call TI	Call TI	Purchase Samples
TRSF3223IDWR	ACTIVE	SOIC	DW	20		TBD	Call TI	Call TI	Purchase Samples
TRSF3223IDWRG4	ACTIVE	SOIC	DW	20		TBD	Call TI	Call TI	Purchase Samples
TRSF3223IPW	ACTIVE	TSSOP	PW	20		TBD	Call TI	Call TI	Purchase Samples
TRSF3223IPWG4	ACTIVE	TSSOP	PW	20		TBD	Call TI	Call TI	Purchase Samples
TRSF3223IPWR	ACTIVE	TSSOP	PW	20		TBD	Call TI	Call TI	Purchase Samples
TRSF3223IPWRG4	ACTIVE	TSSOP	PW	20		TBD	Call TI	Call TI	Purchase Samples

⁽¹⁾ The marketing status values are defined as follows: **ACTIVE:** Product device recommended for new designs.

LIFEBUY: TI has announced that the device will be discontinued, and a lifetime-buy period is in effect.

NRND: Not recommended for new designs. Device is in production to support existing customers, but TI does not recommend using this part in a new design.

PREVIEW: Device has been announced but is not in production. Samples may or may not be available.

OBSOLETE: TI has discontinued the production of the device.



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⁽²⁾ Eco Plan - The planned eco-friendly classification: Pb-Free (RoHS), Pb-Free (RoHS Exempt), or Green (RoHS & no Sb/Br) - please check http://www.ti.com/productcontent for the latest availability information and additional product content details.

TBD: The Pb-Free/Green conversion plan has not been defined.

Pb-Free (RoHS): TI's terms "Lead-Free" or "Pb-Free" mean semiconductor products that are compatible with the current RoHS requirements for all 6 substances, including the requirement that lead not exceed 0.1% by weight in homogeneous materials. Where designed to be soldered at high temperatures, TI Pb-Free products are suitable for use in specified lead-free processes.

Pb-Free (RoHS Exempt): This component has a RoHS exemption for either 1) lead-based flip-chip solder bumps used between the die and package, or 2) lead-based die adhesive used between the die and leadframe. The component is otherwise considered Pb-Free (RoHS compatible) as defined above.

Green (RoHS & no Sb/Br): TI defines "Green" to mean Pb-Free (RoHS compatible), and free of Bromine (Br) and Antimony (Sb) based flame retardants (Br or Sb do not exceed 0.1% by weight in homogeneous material)

⁽³⁾ MSL, Peak Temp. -- The Moisture Sensitivity Level rating according to the JEDEC industry standard classifications, and peak solder temperature.

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DW (R-PDSO-G20)

PLASTIC SMALL-OUTLINE PACKAGE



NOTES: A. All linear dimensions are in inches (millimeters).

B. This drawing is subject to change without notice.

C. Body dimensions do not include mold flash or protrusion not to exceed 0.006 (0,15).

D. Falls within JEDEC MS-013 variation AC.



MECHANICAL DATA

MSSO002E - JANUARY 1995 - REVISED DECEMBER 2001

DB (R-PDSO-G**)

PLASTIC SMALL-OUTLINE

28 PINS SHOWN



NOTES: A. All linear dimensions are in millimeters.

- B. This drawing is subject to change without notice.
- C. Body dimensions do not include mold flash or protrusion not to exceed 0,15.
- D. Falls within JEDEC MO-150



MECHANICAL DATA

MTSS001C - JANUARY 1995 - REVISED FEBRUARY 1999

PW (R-PDSO-G**)

PLASTIC SMALL-OUTLINE PACKAGE

14 PINS SHOWN



NOTES: A. All linear dimensions are in millimeters.

- B. This drawing is subject to change without notice.
- C. Body dimensions do not include mold flash or protrusion not to exceed 0,15.
- D. Falls within JEDEC MO-153



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